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## Distinguishing antiferromagnetic spin sublattices via the spin Seebeck effect

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1	Distinguishing antiferromagnetic spin sublattices via the spin Seebeck effect
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18	We measured spin Seebeck signals at the top and bottom surfaces of an antiferromagnetic Cr <sub>2</sub> O <sub>3</sub>
19	film, using a Pt/Cr2O3/Pt tri-layer. Our experimental data, combined with micromagnetic
20	simulations, clearly demonstrate that the uncompensated sublattice at the top and bottom surfaces
21	plays an decisive role in determining the symmetry of the spin Seebeck signals, providing
22	fundamental insights for understanding the generation of spin Seebeck signal in antiferromagnetic
23	materials.

Recently, antiferromagnetic (AF) materials have become of interest for spin transport 24 applications, where they offer the advantages of zero stray fields, robustness against external field, 25 THz dynamics, and abundance of available materials. Recent studies have demonstrated many 26 intriguing phenomena in AF materials, including anisotropic magnetoresistance [1], anomalous 27 Hall effects [2], anomalous Nernst effects [3], spin Hall effects giving rise to spin-orbit torques 28 [4,5], and electrical manipulation of the Néel vector [6]. These developments make AF materials 29 promising for the next generations of spin-based technologies [7-11]. Towards this end, the ability 30 to generate, transport, and detect spin currents in AF insulators have been the focus of recent studies 31 [12]. The transport of spin current in insulators can be realized in the form of magnon currents 32 without associated Joule heating; thus magnon based devices may have the potential to carry and 33 propagate information with low power dissipation [13,14]. Recent studies have demonstrated that 34 AF materials are ideal media to excite and propagate magnons. AF magnons can be excited both 35 thermally [15,16] and resonantly [17]. AF magnon can carry spin information over a few tens of 36 micros [18] and can be switched on or off by manipulating the AF states [19]. Theory also predicts 37 38 that antiferromagnets may support spin super-fluidity [20]. Therefore, AF insulators have become promising candidates for magnon based devices. 39

The spin Seebeck effect (SSE) [21-23] provides an ideal platform to study magnon-related phenomena. The SSE occurs in a magnetic/non-magnetic bilayer. A temperature gradient in the magnetic layer  $\nabla T$  generates a magnon current  $\overline{J_s}$  carrying spin angular momentum  $\overline{\sigma}$ , flowing along  $\nabla T$ . This spin current is injected into the adjacent non-magnetic layer, and if that layer has strong spin-orbit coupling (such as Pt, W), the spin current will subsequently be converted into a measurable electrical voltage through the inverse spin Hall effect. The associated voltage  $V_{SSE}$  is given by:

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$$V_{SSE} \propto \rho L_{\nu} \theta_{SH} (\overline{J}_{s} \times \overline{\sigma})$$
<sup>(1)</sup>

Here,  $\theta_{SH}$  is the spin Hall angle of the heavy metal layer,  $\rho$  is the resistivity of the nonmagnetic later, and  $L_{\nu}$  is the separation between the electrodes for the voltage measurement. Although the generation of SSE in AF insulators has been demonstrated several years ago [15,16], its microscopic origin is still not well understood. Theoretically, both surface [24] and bulk [25,26] mechanisms for SSE of AF materials have been proposed. But experimentally this issue remains unresolved.

Recently, Gray *et al.* have demonstrated that the SSE is sensitive to the surface sublattice [27]. They 53 developed a magnetothermal microscopy to image the magnetic state in NiO. They found the SSE 54 signal is much larger for uncompensated surfaces than for compensated surface. Based on the fact 55 that the temperature gradient is dominant at the Pt/NiO interface when using use picosecond laser 56 57 as a heating source, their results indicate that the contrast in SSE images is due to the surface SSE in AF materials, and is determined by the extra sublattice at the uncompensated surface. However, 58 it should be noted that the ultra-fast laser pulse could also result in various other magneto-optical 59 effects [28]. For example, it has been established that the uncompensated surface of NiO (111) 60 could induce larger collinear magnetic difference-frequency generation than other compensated 61 62 surfaces, which can also contribute to electrical signals [29, 30]. Thus, a direct characterization of the relationship between the surface sublattice and SSE signals, still needs to be established, but 63 remains challenging to realize experimentally. Due to the unavoidable existence of atomic steps 64 and surface roughness, the uncompensated surface of a normal AF material will have the last extra 65 surface sublattices distributed randomly. The coexistence of two antiparallel sublattices makes it 66 67 difficult to establish a qualitative relationship between the surface sublattice and the SSE signal.

In our work, we avoid the coexistence of two surface sublattices by using  $Cr_2O_3$ . The spin-68 69 polarized (0001) surface of  $Cr_2O_3$  provides an ideal system to characterize the relationship between the surface sublattice and the SSE signal [31]. We measured the SSE signals at the top and bottom 70 surfaces of Cr<sub>2</sub>O<sub>3</sub>. We find the SSE signals at opposite surfaces exhibit distinguishable angular 71 72 dependent symmetry, which is in direct contrast with results in Pt/YIG/Pt structure, where the signature at the top and bottom surfaces are identical [32]. Combined with micromagnetic 73 simulation, we found the distinguishable SSE signal at the top and bottom represent the individual 74 magnetic response of the two antiparallel sublattices in Cr<sub>2</sub>O<sub>3</sub>, providing a qualitative 75 demonstration of the role of the surface spins in controlling the SSE signal. 76

Figure 1(A) illustrates the configuration of the  $Cr_2O_3$  (0001) surface. The antiparallel  $Cr^{3+}$  ion spins align along the c-axis (z-direction). Within an AF domain at the (0001) surface, the  $Cr^{3+}$  ion spins are parallel aligned even with surface steps, exhibiting a long-range magnetic order. Besides, due to the different relative positions with respect to the  $O^{2-}$  ions, the  $Cr^{3+}$  spins at the top and bottom surfaces are opposite, which represent the two different sublattices. This unique spin structure is due to the requirements of charge-neutrality and the nature of interlayer antiferromagnetic coupling in  $Cr_2O_3$  [31].



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Fig.1 (A) Illustration of the spin structure of a  $Cr_2O_3$  single crystal with a stepped (0001) surface. The red arrows point along the *c* axis denote the spin direction of  $Cr^{3+}$  ions. (B)  $\theta$ -2 $\theta$ X-ray diffraction pattern of a 180-nm  $Cr_2O_3$  film (lower panel) and  $Cr_2O_3$  (180 nm)/Pt(5 nm) bilayer (upper panel), respectively. The films are deposited on Al<sub>2</sub>O<sub>3</sub> (0001) substrates. (C) Experimental setup of the SSE measurements. The left figure is the top view of the device. The insert on the right shows the cross-section of the sample structure.

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The Cr<sub>2</sub>O<sub>3</sub> film is grown by reactive magnetic sputtering. Figure 1(B) shows the X-ray diffraction (XRD) of a 180-nm Cr<sub>2</sub>O<sub>3</sub> layer grown on an Al<sub>2</sub>O<sub>3</sub> (0001) substrate with and without Pt bottom layer. The red and blue lines are the standard (0006) peak positions for Cr<sub>2</sub>O<sub>3</sub> and Al<sub>2</sub>O<sub>3</sub>, respectively [33]. Cross-sectional transmission electron microscopy (TEM) images also show that Cr<sub>2</sub>O<sub>3</sub> is an epitaxial single-crystal (see the Supplemental Material for details [34]).

FIG. 1 (C) summarizes the sample structure and experiment set-up. We grow a Pt(5 nm)/Cu(2 nm)/Cr<sub>2</sub>O<sub>3</sub>(180 nm)/Pt(5 nm) layer stack. Here the insertion of 2-nm Cu at the top Pt/Cr<sub>2</sub>O<sub>3</sub> interface avoids possible proximity effects [35] and detrimental interfacial anisotropies[36]. The films are patterned into 800  $\mu$ m × 20  $\mu$ m Hall-bar structures for transport measurement, as shown in the left panel of Fig. 1(C). In order to provide a temperature gradient during the SSE measurements, we deposit a Ti/ Si<sub>3</sub>N<sub>4</sub> layer on top of the film stack, to serve as a resistive heater. The resistance between the top Pt and Ti, and between the top and bottom Pt layer is larger than 20 M $\Omega$  at 100 K, demonstrating the good electrical insulation of Si<sub>3</sub>N<sub>4</sub> and Cr<sub>2</sub>O<sub>3</sub>. The right panel of Fig. 1(C) shows a cross-section of the sample structure (see the Supplemental Material for details [34]).

During the measurement, we send a sinusoidal current (3 Hz) through the Ti heater ( $P_{heating} \sim 5 \text{ mWrms}$ ), which generates a temperature gradient  $\nabla T$  normal to the film plane. The resulting  $V_{sse}$  at the top and bottom Pt layers are measured using lock-in techniques at the second harmonic. We apply magnetic fields with different amplitudes in the *y*-*z* plane, as shown in the inset of Fig 1(C).

Figure 2 shows the angular dependence of the SSE signals at different applied magnetic fields at 111 100 K. We observe a transition at 7.5 T. Below 7.5 T, the SSE voltages at the top and bottom 112 surfaces do not show hysteresis when the field is rotated from 0° to 360° and rotated back from 113  $360^{\circ}$  to  $0^{\circ}$ , while a clear hysteresis appears above that. The rotational symmetry also changes across 114 the transition field. At fields below 7.5 T, the signals at the top and bottom are antisymmetric about 115  $\theta_{\mu} = 180^{\circ}$ . While after the transition, the signals before and after  $\theta_{\mu} = 180^{\circ}$  exhibit a 180° phase 116 shift and sign reversal. In the simulation part, we demonstrated that this transition is due to the spin 117 118 flop transition. The spin flop field for bulk Cr<sub>2</sub>O<sub>3</sub> is about 6.5 T, while in our thin films, it shifts to 7.5 T, this may due to the strain that exists in the epitaxial film. Another important observation is 119 120 that the SSE signals at the top and bottom surfaces can be clearly distinguished. Both before and 121 after the transition, the rotational SSE signals from the two surfaces exhibit different shapes, with maxima in their amplitudes realized at different field directions. The distinguishable SSE signals at 122 the different surfaces are in direct contrast to the identical SSE signals at the top and bottom surfaces 123 of ferromagnetic material [32]. 124

The magnitude of the SSE signal is proportional to the heating power (see the Supplemental Material for details [34]), suggesting the thermoelectric nature of the signal. By performing the thermometry at the top and bottom Pt layers [32], the temperature difference across the Cr<sub>2</sub>O<sub>3</sub> is determined as  $|\overline{\nabla}T| = 0.043 K$  at 100 K. The similar rotational symmetry and the transition behavior can be observed between 70 K and 200 K (see the Supplemental Material for details [34]). At the top surface, the signals are qualitatively the same as those that we measured at the bottom surface, even with the insertion of 2-nm Cu. This indicates the spin current generated in the AF can cross
through Cu and convert to a charge current in Pt. The measured signals are dominated by SSE and
any contribution of the Nernst effect is negligible.





Fig. 2 Angular dependence of the SSE voltages at the top and bottom surfaces of  $Cr_2O_3$  at different fields. In (A) and (B), The upper figures represent the signals measured at the top Pt layer, while the lower figures represent the signals measured at the bottom Pt layer. The magenta and light blue colors represent the signals when the field rotate  $0^{\circ} \rightarrow 360^{\circ}$  and back  $360^{\circ} \rightarrow 0^{\circ}$ , respectively. The temperature during these measurements was 100 K.

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We notice the SSE amplitudes at the top surface are larger than at the bottom, even with the insertion of Cu. This is mainly due to the different Pt resistances at the top and bottom, see Eq. (1). The resistance of the top Pt, even with the Cu insertion layer, is higher than that of the bottom Pt, resulting in the larger amplitude of SSE (see the Supplemental Material for details [34]). The resistance difference between the two Pt layers is presumably due to the different roughness or microstructure when Pt is grown on the Al<sub>2</sub>O<sub>3</sub> substrate and Cr<sub>2</sub>O<sub>3</sub>.

To better understand the SSE signal, we simulated the magnetic response of  $Cr_2O_3$  at different fields. Considering  $Cr_2O_3$  is a layered antiferromagnet along the *c*-axis [(0001) plane], we model our system with 30 magnetic layers, with magnetic moments ferromagnetically coupled in the same layer, while antiferromagnetically coupled between adjacent layers. Considering the different microstructure (with Cu insertion at the top surface) and morphologies at the top and bottom surface, we slightly reduce the anisotropy at the top surface (see the Supplemental Material for details [34]). We simulate the angular dependence of the sublattice moments at fields below (6 T) and above the spin-flop transition (8 T). Fig. 3 (A) and (G) plot the angular dependence of the inplane magnetization component  $(m_y)$  at the top surface  $(m_y^{i=30})$ , bottom surface  $(m_y^{i=1})$ , and the net magnetization  $\sum_{i=1}^{30} m_y^i$ , when 6 T and 8 T magnetic fields are applied in the *y*-*z* plane. Fig. 3 (B)-(E) and (G)-(K) plot the magnetization configurations at selected field orientations.

The simulation results at a 6 T field are plotted in Fig. 3 (A-E). When the field rotates in the *y*-*z* plane, the sublattices tilt from the easy axis, resulting in an in-plane component  $m_y$ . As shown in Figs. 3(B), (C), and (D), due to the locally different effective fields, the two sublattices exhibit different line shapes of  $m_y^{i=1}$  and  $m_y^{i=30}$ , and different value of  $\theta_H$  for the maxima SSE amplitudes. At 6 T field the sublattices only tilt from the easy axis, which is reversible when the field rotates clockwise and counterclockwise.



Fig. 3. Simulation of the angular magnetic field dependence of the sublattice moments at 6 T and 8 T, respectively. In (A) and (F), from top to down, are plots of the normalized  $m_y$  at the bottom surface  $(m_y^{i=1})$ , top surface  $(m_y^{i=30})$ , and the net moment  $(\sum_{i=1}^{30} m_y^i)$ . The sold and dash lines represent the field rotate  $0^{\circ} \rightarrow$ 360° and rotate back 360°  $\rightarrow$  0°, respectively. The blue dashed lines are guidelines for the selected field angles  $\theta_H$ , at which the magnetization configurations are plotted, as (B) – (E) and (G) – (J) show. The small arrows in (B) – (E) and (G) – (J) indicate the sublattices in each layer. The colors denote  $m_y$ , as shown in the color bar. The number on the left side of (B) and (F) denote the layer number *i*.

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When the 8-T field is applied along the easy axis, the magnetic configuration transforms into a non-uniform state, as shown in Fig. 3(G), the top and bottom surfaces are parallel with the field, with a domain wall located in the center of the stack. This is known as a surface spin flop transition and has been studied extensively theoretically and experimentally [37,38]. This phenomenon origin from the reduced coordination at the AF surfaces, where the sublattices at the top and bottom

surfaces of an AF film have decreased exchange coupling. When a magnetic field is applied, the 177 surface sublattice that is antiparallel with the field flips first, and then penetrates into the bulk, 178 leading to non-uniform spin states from the center to the surface. The initial domain wall thickness 179 is determined by the exchange coupling and anisotropy, and we estimated this for Cr<sub>2</sub>O<sub>3</sub> to be about 180 4.4 nm. This sets the minimum length-scale for the spin-flopped domain wall, which with 181 increasing magnetic field will extend throughout the whole thickness of the Cr<sub>2</sub>O<sub>3</sub> [37, 38]. Rotating 182 the magnetic field in the y-z plane results in a motion, annihilation, and nucleation of the domain 183 wall, accompanied by the flipping of the sublattices. The flip of the sublattices changes the 184 rotational symmetry of surface sublattices  $m_v^{i=1}$  and  $m_v^{i=30}$  compared to that at 6 T field (see the 185 Supplemental Material for details [34]). 186

A direct comparison of the simulation results in Fig. 3 with the SSE voltages in Fig. 2 shows that 187 the direction of the surface sublattices moments dominates the SSE signal. On the other hand, the 188 189 bulk magnetic order (net moment) is not correlated with the experimentally observed angular dependence of the SSE signals. Therefore, our results qualitatively establish the relationship 190 191 between the surface sublattice and the SSE in AF materials. Furthermore, our methods can help to distinguish different antiparallel spin states in Cr<sub>2</sub>O<sub>3</sub>. Fig. 4 show the angular dependence of the 192 SSE signals for two different antiparallel spin states. The distinguishable line shapes at the top and 193 bottom help to distinguish the individual sublattice direction at the surfaces, and further the different 194 antiparallel spin states in uniaxial antiferromagnets. This finding allows us to directly probe 195 196 electrically and independently the individual sublattices in an antiferromagnet via simultaneously measuring spin Seebeck effects at opposite surfaces. To our knowledge, apart from techniques that 197 probe individual spin in antiferromagnets directly (such as spin-polarized scanning tunneling 198 microscopy), there are few other techniques that can provide independent information for each 199 sublattice independently. 200

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Fig.4 Distinguishing opposite sublattice configuration in uniaxial  $Cr_2O_3$ . (A) and (B) show the angular dependence of the SSE signals at the top and bottom surfaces with opposite initial sublattice directions, indicated by the insets. The temperature during the measurements was 100 K. The field amplitude is 6 T.

It is possible that multi-domains with opposite surface sublattices could exist in the devices. To 206 study the influence of a multi-domain state, we simulate the angular dependence of  $M_{y}$  with 207 different degrees of multi-domain states, i.e., different percentages of  $M_A$  and  $M_B$  (see the 208 Supplemental Material for details [34]). We find the line shape of  $M_y$  change from non-sinusoidal 209 to sinusoidal when the degree of multi-domains increases. The non-sinusoidal line shape observed 210 in our samples indicates that the multi-domain states are low ( $M_B$  below 10%) and most of the top 211 and bottom sublattices rotate coherently with the field. However, in devices without Cu inserted at 212 the top surface, the line shape at the top surface exhibits sinusoidal behavior (see the Supplemental 213 Material for details [34]), this indicates the insert of Cu may also influence surface anisotropies, 214 215 which makes the top sublattice easy to be manipulated by field.

In previous experiments, an ultrafast laser pulse was used as the heating source, by which the temperature gradient  $\nabla T$  is dominated at the Pt/AF interface [27] and concomitantly the surface sublattices play a dominating role in determining the SSE signal. In contrast, in our study, we use low-frequency AC current (3 Hz) as the heating source, where the  $\nabla T$  in the bulk of AF material is dominant [27] (see the Supplemental Material for details [34]). Our results further demonstrate that even with the temperature gradient in the bulk of AF material, the SSE is still dominated by the surface sublattices. Given that our simulations suggest a significant rotation of the surface spins with respect to the bulk structure, the question then arises how angular momentum associated with bulk magnon modes gets modified near the interface, and what role the excitations of the interface spins themselves play. Therefore, further theoretical and experimental work will be necessary to understand the magnon current driven by temperature gradient and resulting spin currents in the interfacial region.

In conclusion, we qualitatively characterize the relationship between the sublattices and the SSE signals, demonstrating the role of interface spin sublattices in determining the symmetry and hysteretic behavior, which can shed light on understanding the various surface sensitive SSE behaviors [17].

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